

Notice of References Cited	Application/Control No. 10/629,408	Applicant(s)/Patent Under Reexamination RATASUK ET AL.	
	Examiner Brad T. Mace	Art Unit 2663	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-2004/0082301	04-2004	Agin, Pascal	455/127.1
	B	US-2002/0054578	05-2002	Zhang et al.	370/328
	C	US-2002/0102983	08-2002	Furuskar et al.	455/452
	D	US-2002/0075831	06-2002	Lozano, Angel	370/335
	E	US-6,278,701	08-2001	Ayyagari et al.	370/335
	F	US-2003/0112784	06-2003	Lohtia et al.	370/342
	G	US-6,744,744	06-2004	Tong et al.	370/320
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title, Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(e).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.

Notice of References Cited	Application/Control No. 10/629,408	Applicant(s)/Patent Under Reexamination RATASUK ET AL	
	Examiner Christine Ng	Art Unit 2663	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-6,473,442	10-2002	Lundsjo et al.	370/537
	B	US-			
	C	US-			
	D	US-			
	E	US-			
	F	US-			
	G	US-			
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)
Dates in MM-YYYY format are publication dates. Classifications may be US or foreign.